

**Search Notes**

Application/Control No.

10/068,159

Examiner

Thao P. Le

Applicant(s)/Patent under  
Reexamination

TAN ET AL.

Art Unit

2818

**SEARCHED**

Class	Subclass	Date	Examiner
257	777	4/27/2007	T.LE
257	778	4/27/2007	T.LE
257	E23.069	4/27/2007	T.LE

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
interference (see note)		4/27/2007	T.LE

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
east (see note)	4/27/2007	T.LE
IDS + east (see search)	4/27/2007	T.LE